

## N THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Confirmation No. 7118

Mitsuo TADA et al.

Docket No. 2001 1568A

Serial No. 09/982,025

Group Art Unit 2862

Filed October 19, 2001

Examiner Walter E. Snow

FREQUENCY MEASURING DEVICE, POLISHING DEVICE USING THE SAME AND EDDY CURRENT SENSOR

THE COMMISSIONER IS AUTHORIZED TO CHARGE ANY DEFICIENCY IN THE FEES FOR THIS PAPER TO DEPOSIT ACCOUNT NO. 23-0975

## **SUBMISSION OF CORRECTED FORM PTO-1449**

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Submitted herewith is a corrected PTO Form-1449 to correctly identify Document AB listed on the PTO Form-1449 filed on August 13, 2003 as U.S. Patent No. 5,644,221 to Li et al. Document AB listed on the August 13, 2003 PTO Form-1449 was incorrectly listed as U.S. Patent No. 5,664,221 to Li et al. A copy of U.S. Patent No. 5,644,221 was submitted with the Information Disclosure Statement and Form PTO-1449 filed on August 13, 2003. Also submitted herewith is a copy of the August 13, 2003 PTO-Form 1449 with the correction of Document AB made thereon in red.

Bv:

Respectfully submitted,

Mitsuo TADA et al.

Jonathan R. Bowser

Registration No. 54,574

Attorney for Applicants

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September 24, 2003

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FORM PTO 1449 (modified) SEP 2 & 2003						SERIAL N					
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OF THE LIST OF REFERENCES CITED BY APPLICANTS TRADET (Use several sheets if necessary)			APPLICANT Mitsuo TADA et al.								
			FILING DATE			GROUP					
Date Submitted to PTO: September 24, 2003				October 19, 2001				2862			
U.S. PATENT DOCUMENTS											
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME CLASS SUBCLASS					FILING DATE IF APPROPRIATE		
	AA	5,559,428	9-1996	L	i et al.						
	AB	5,644,221	7-1997	L	i et al.						
	AC	5,659,492	8-1997	l	i et al.						
	AD	5,660,672	8-1997	L	i et al.						
	AE	5,663,637	9-1997	L	i et al.						
	AF	5,770,948	9-1998	L	i et al.						
	AG	6,563,308	5-2003	Nag	jano et al.						
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				APPLICANT Mitsuo TADA et al.						
(Use several sheets if necessary)  Date Submitted to PTO: August 13, 2003				FILING DATE October 19, 2001	GROUP 2862					
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
	ΑA	5,559,428	9-1996	Li et al.						
	AB	5,644,221 4,664,221	7-1997	Li et al.						
	AC	5,659,492	8-1997	Li et al.						
	AD	5,660,672	8-1997	Li et al.		·				
	AE	5,663,637	9-1997	Li et al.						
	AF	5,770,948	9-1998	Li et al.			· · · · · · · · · · · · · · · · · · ·			
	AG	6,563,308	5-2003	Nagano et al.						
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.